

Device Modeling Report

COMPONENTS: MOSFET (Professional)
PART NUMBER: 2SJ349
MANUFACTURER: TOSHIBA
Body Diode (Professional) / ESD Protection



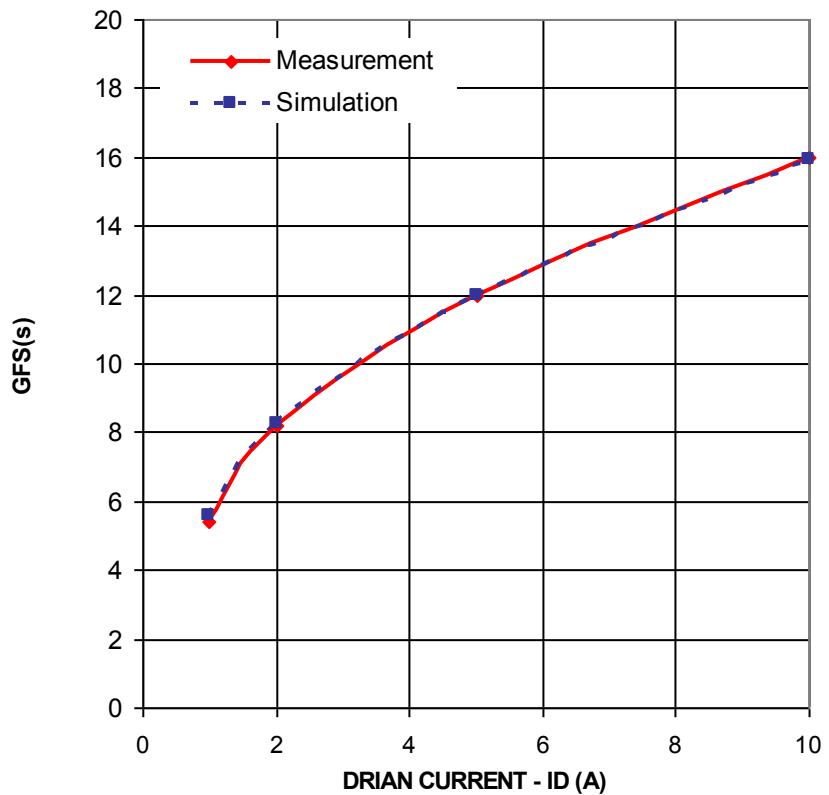
Bee Technologies Inc.

MOSFET MODEL PARAMETERS

PSpice model parameters	Model description
LEVEL	
L	Channel Length
W	Channel Width
KP	Transconductance
RS	Source Ohmic Resistance
RD	Ohmic Drain Resistance
VTO	Zero-bias Threshold Voltage
RDS	Drain-Source Shunt Resistance
TOX	Gate Oxide Thickness
CGSO	Zero-bias Gate-Source Capacitance
CGDO	Zero-bias Gate-Drain Capacitance
CBD	Zero-bias Bulk-Drain Junction Capacitance
MJ	Bulk Junction Grading Coefficient
PB	Bulk Junction Potential
FC	Bulk Junction Forward-bias Capacitance Coefficient
RG	Gate Ohmic Resistance
IS	Bulk Junction Saturation Current
N	Bulk Junction Emission Coefficient
RB	Bulk Series Resistance
PHI	Surface Inversion Potential
GAMMA	Body-effect Parameter
DELTA	Width effect on Threshold Voltage
ETA	Static Feedback on Threshold Voltage
THETA	Mobility Modulation
KAPPA	Saturation Field Factor
VMAX	Maximum Drift Velocity of Carriers
XJ	Metallurgical Junction Depth
UO	Surface Mobility

Transconductance Characteristic

Circuit Simulation Result

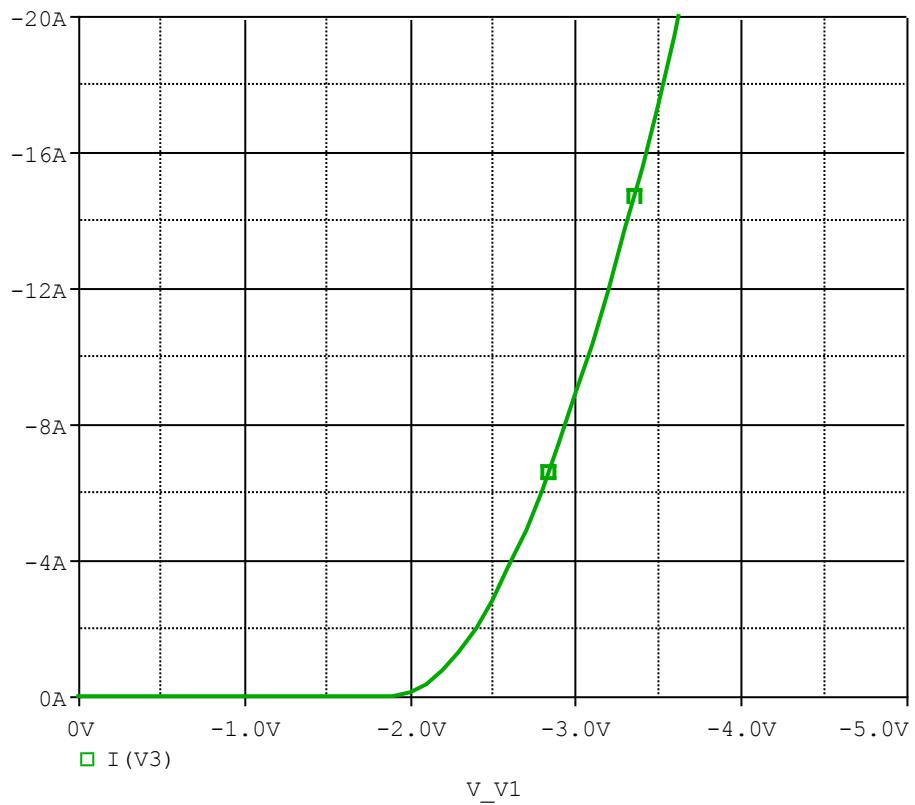


Comparison table

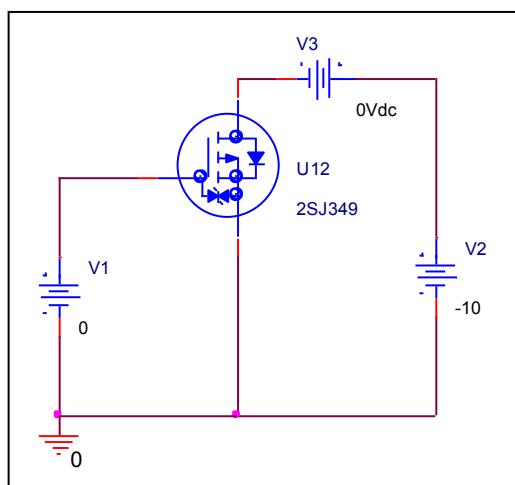
Id(A)	Gfs(S)		Error(%)
	Measurement	Simulation	
-1.000	5.400	5.556	2.889
-2.000	8.200	8.245	0.549
-5.000	12.000	11.992	-0.067
-10.000	16.000	15.920	-0.500

V_{gs}-I_d Characteristic

Circuit Simulation result

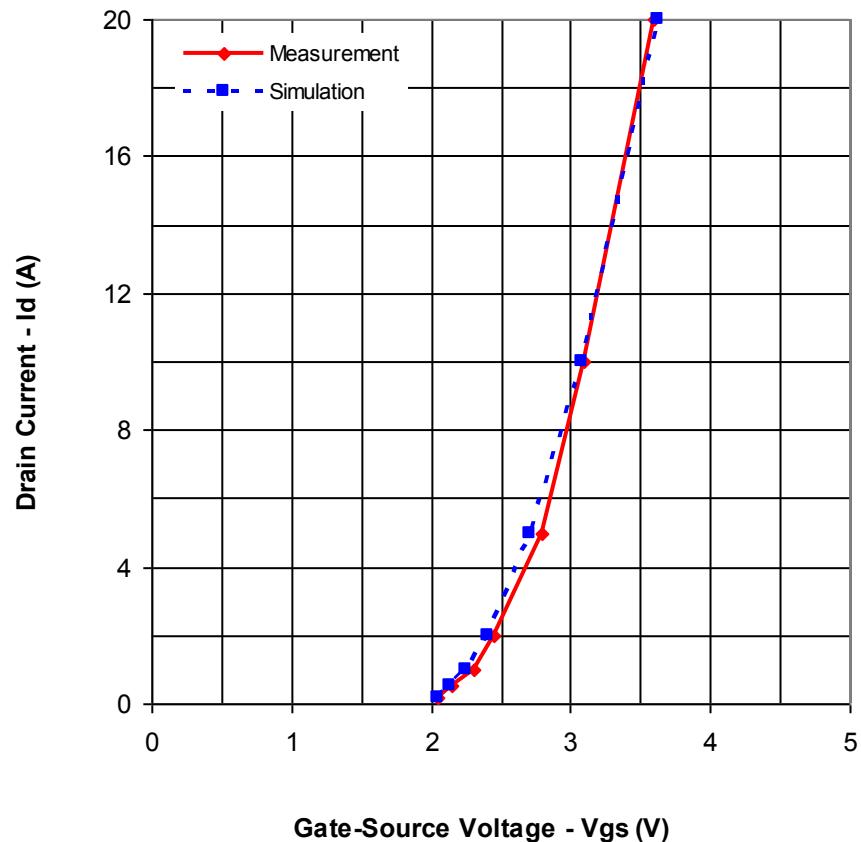


Evaluation circuit



Comparison Graph

Circuit Simulation Result

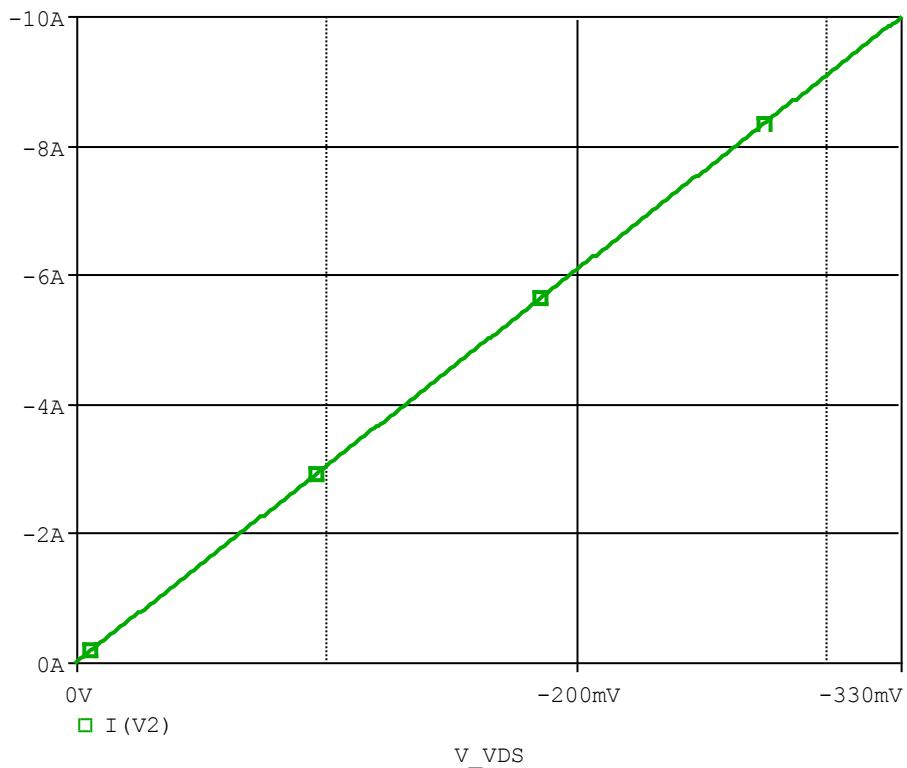


Simulation Result

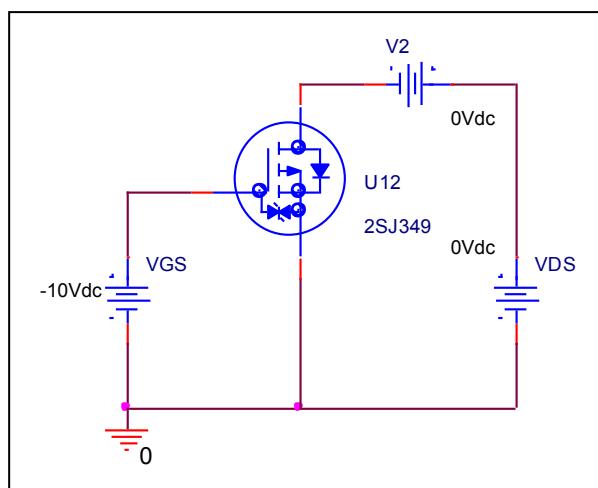
I_D (A)	V_{GS} (V)		Error (%)
	Measurement	Simulation	
-0.200	-2.050	-2.043	-0.341
-0.500	-2.150	-2.136	-0.651
-1.000	-2.300	-2.245	-2.391
-2.000	-2.450	-2.401	-2.000
-5.000	-2.800	-2.710	-3.214
-10.000	-3.100	-3.078	-0.710
-20.000	-3.600	-3.628	0.778

R_{ds(on)} Characteristic

Circuit Simulation result



Evaluation circuit

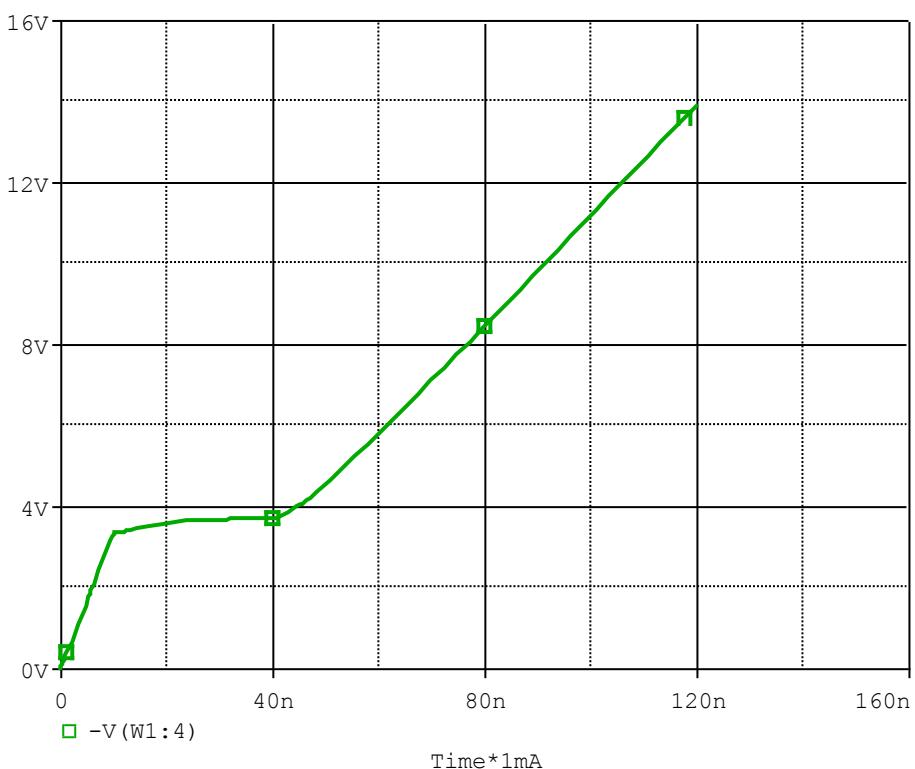


Simulation Result

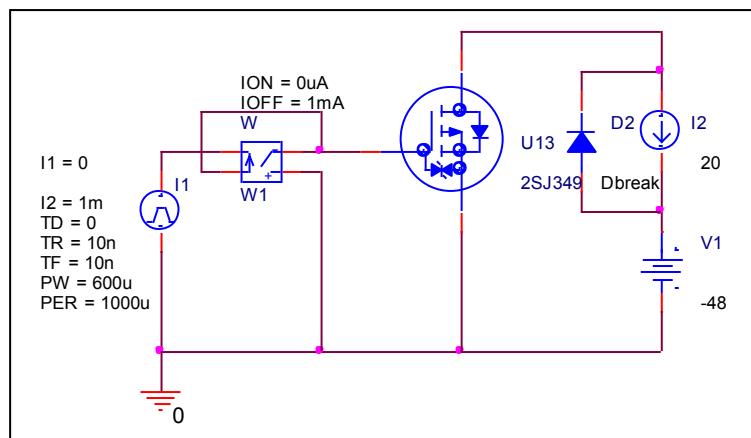
I _D =-10A, V _{GS} =-10V	Measurement		Simulation		Error (%)
R _{DS} (on)	33.000	mΩ	33.000	mΩ	0.000

Gate Charge Characteristic

Circuit Simulation Result



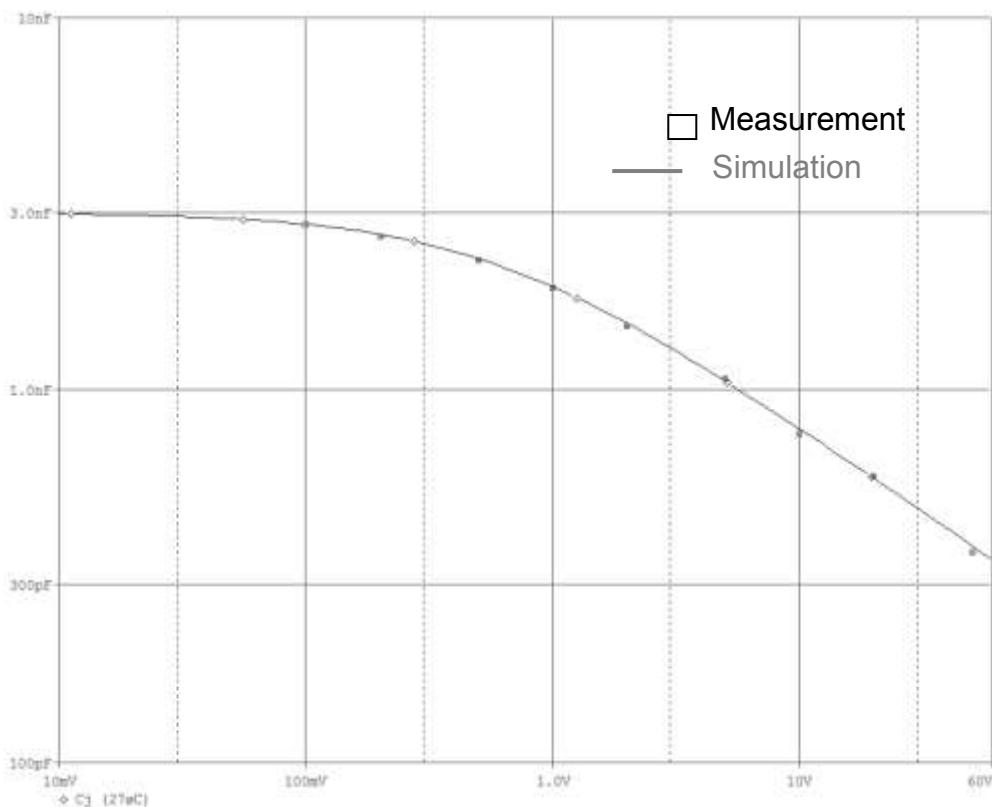
Evaluation Circuit



Simulation Result

$V_{DD} = -48V$, $I_D = -20A$, $V_{GS} = -10V$	Measurement		Simulation		Error (%)
Q_{gs}	10.000	nC	10.070	nC	0.700
Q_{gd}	31.000	nC	30.909	nC	-0.294
Q_g	90.000	nC	91.469	nC	1.632

Capacitance Characteristic

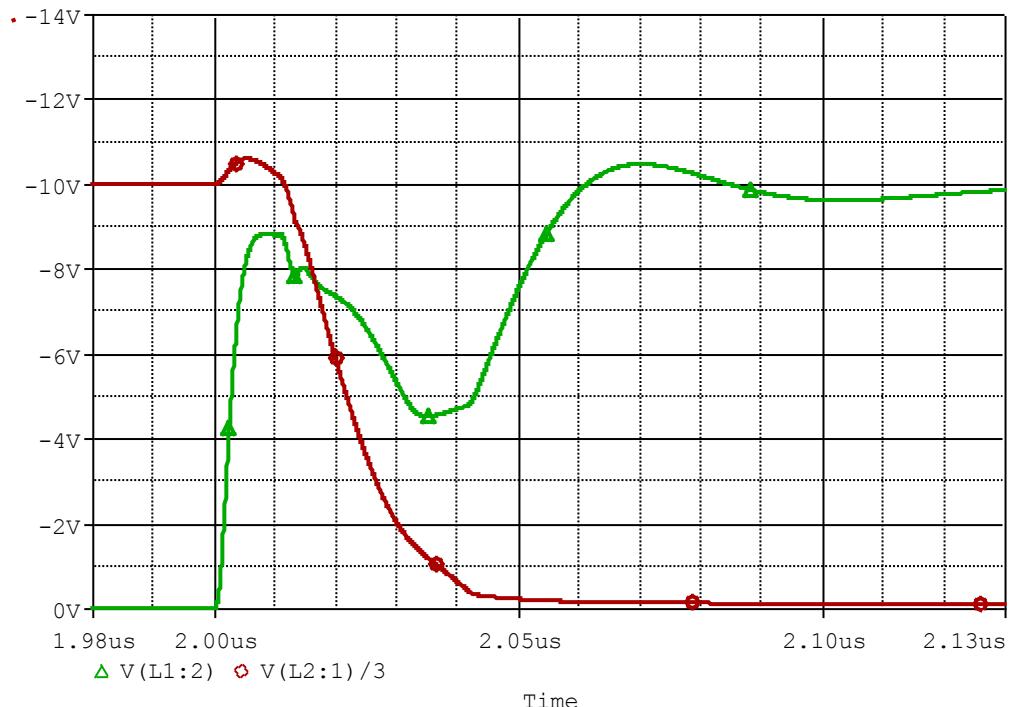


Simulation Result

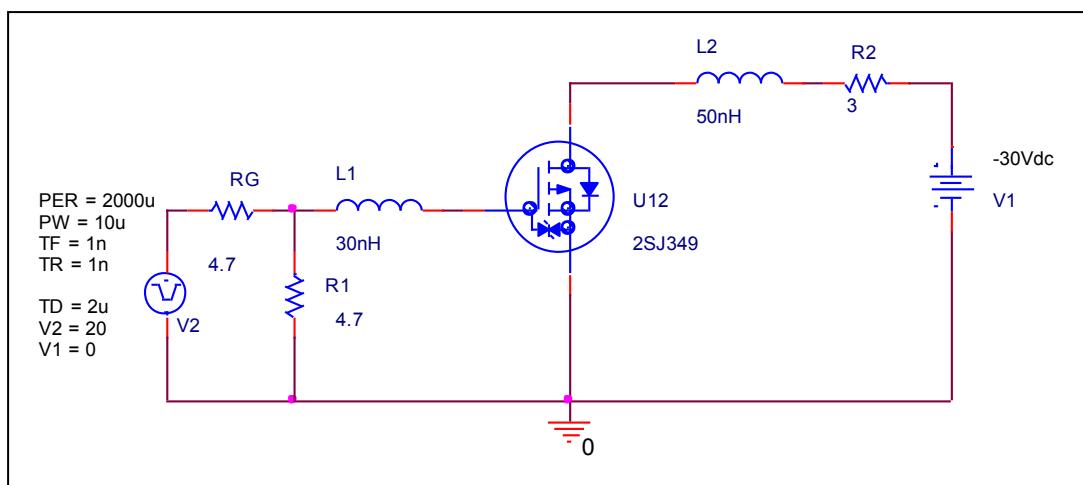
V_{ds} (V)	Cbd(pF)		Error(%)
	Measurement	Simulation	
0.100	2800.000	2750.000	-1.786
0.200	2500.000	2550.000	2.000
0.500	2200.000	2200.000	0.000
1.000	1900.000	1900.000	0.000
2.000	1500.000	1550.000	3.333
5.000	1080.000	1100.000	1.852
10.000	750.000	770.000	2.667
20.000	590.000	590.000	0.000
50.000	370.000	360.000	-2.703

Switching Time Characteristic

Circuit Simulation Result



Evaluation Circuit

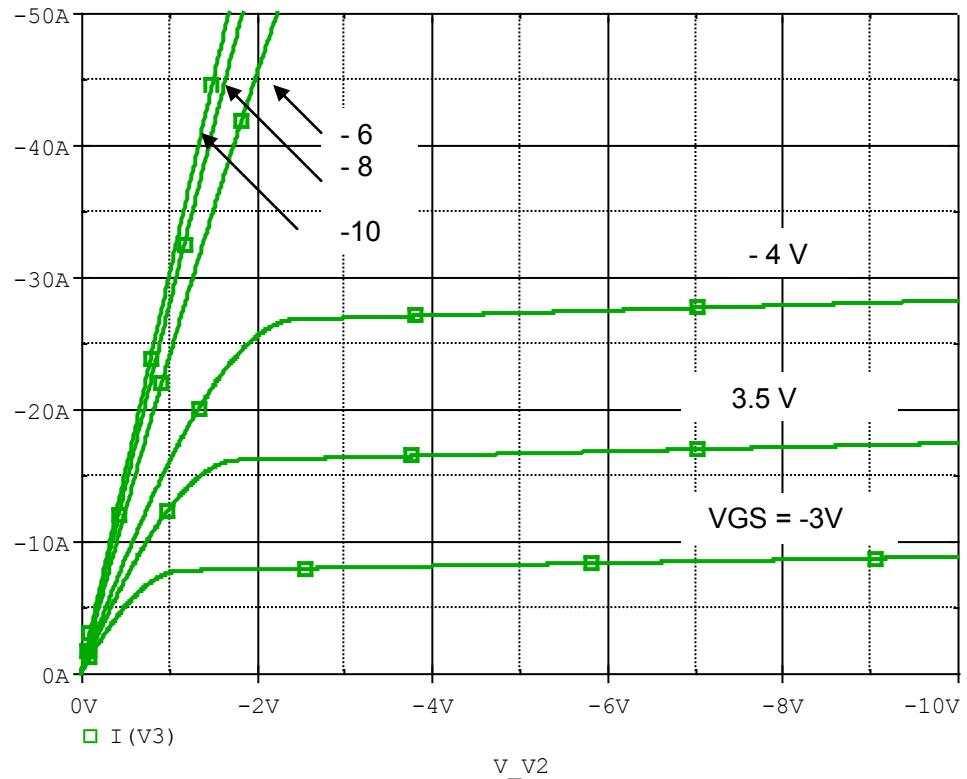


Simulation Result

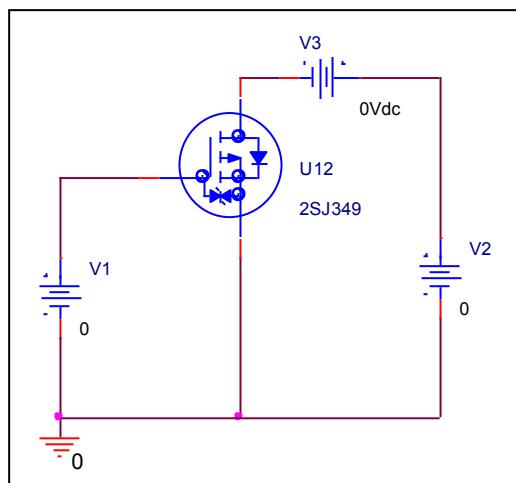
$I_D = -10A$, $V_{DD} = -30V$, $V_{GS} = -10V$	Measurement	Simulation	Error(%)
$T_d(on)$	35.000 ns	35.565 ns	1.614

Output Characteristic

Circuit Simulation Result

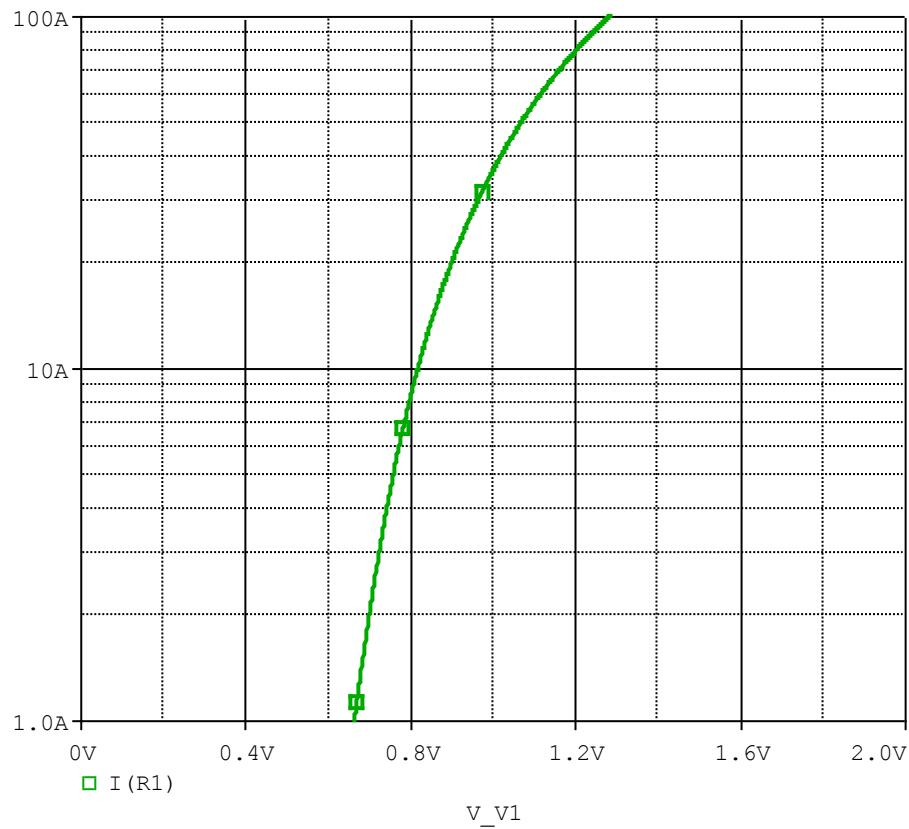


Evaluation Circuit

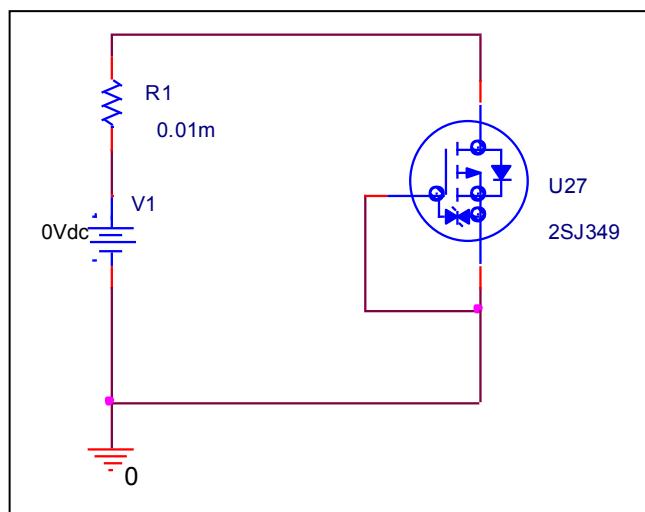


Forward Current Characteristic

Circuit Simulation Result

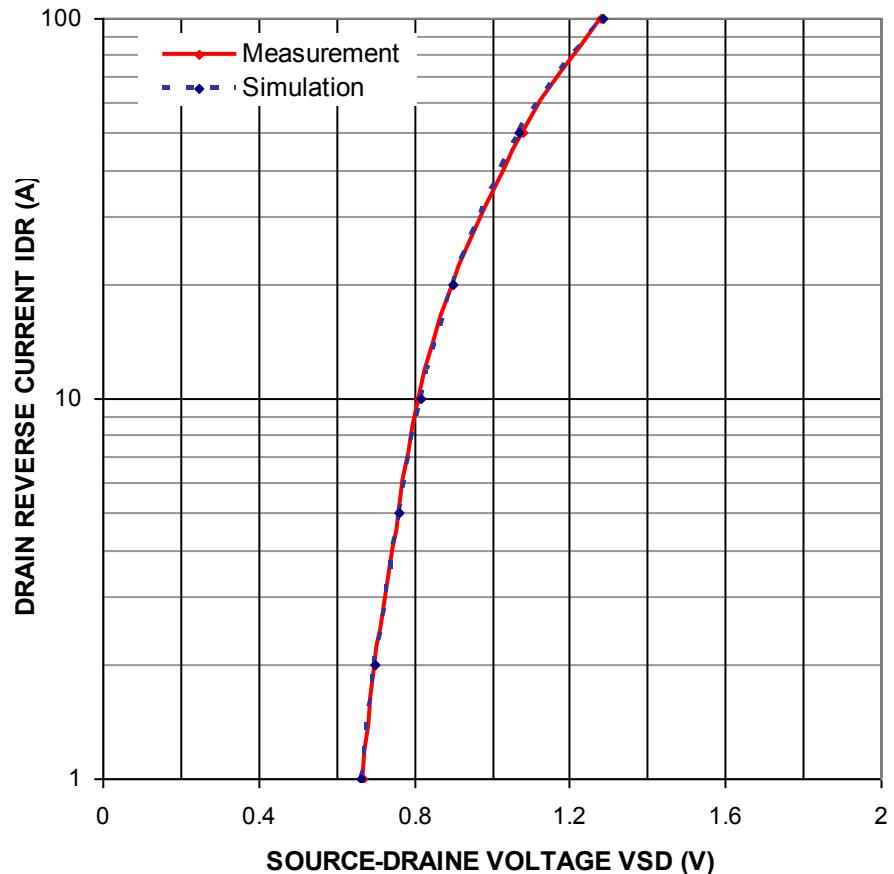


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

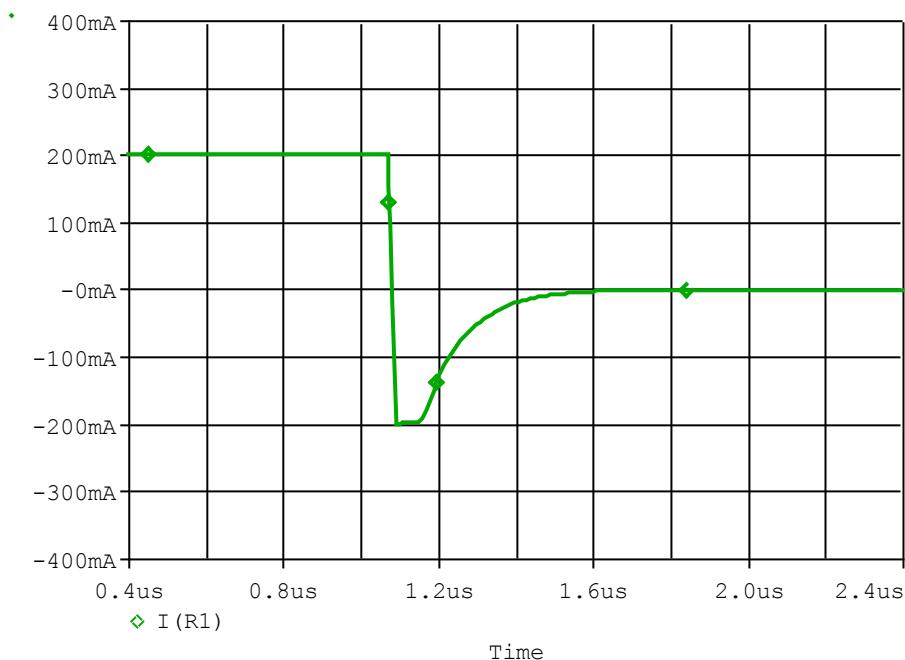


Simulation Result

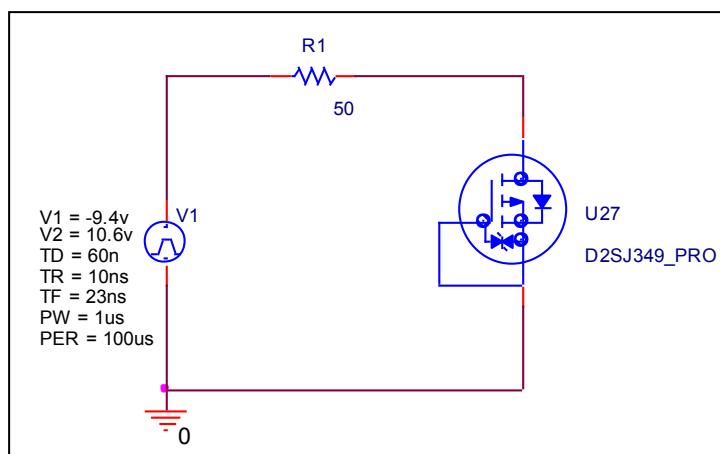
IDR(A)	VSD(V)		%Error
	Measurement	Simulation	
1.000	0.670	0.665	-0.746
2.000	0.700	0.701	0.143
5.000	0.760	0.759	-0.132
10.000	0.810	0.819	1.111
20.000	0.900	0.901	0.111
50.000	1.080	1.071	-0.833
100.000	1.280	1.286	0.469

Reverse Recovery Characteristic (Body Diode)

Circuit Simulation Result



Evaluation Circuit

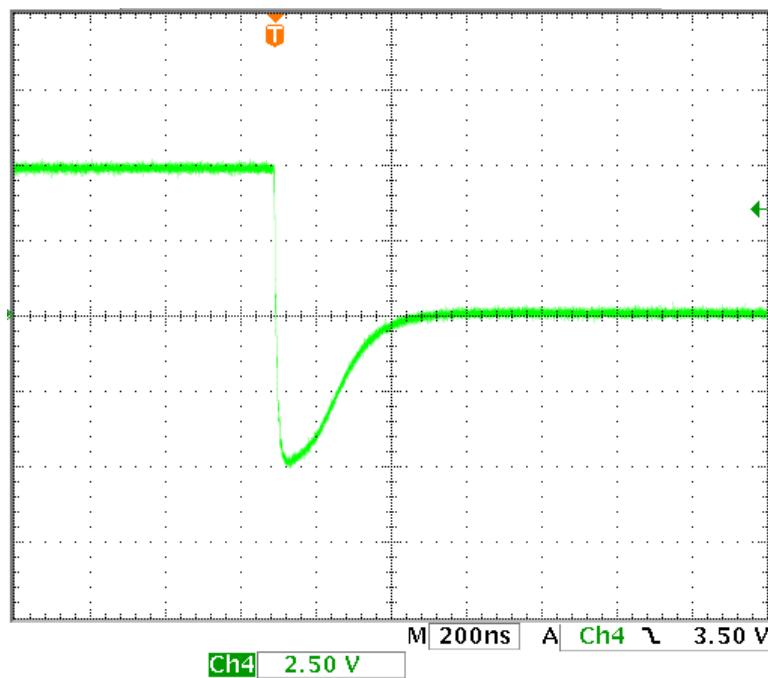


Compare Measurement vs. Simulation

	Measurement		Simulation		Error (%)
trj	72.000	ns	71.683	ns	-0.440
trb	245.000	ns	245.614	ns	0.251
trr	317.000	ns	317.297	ns	0.094

Reverse Recovery Characteristic (Body Diode)

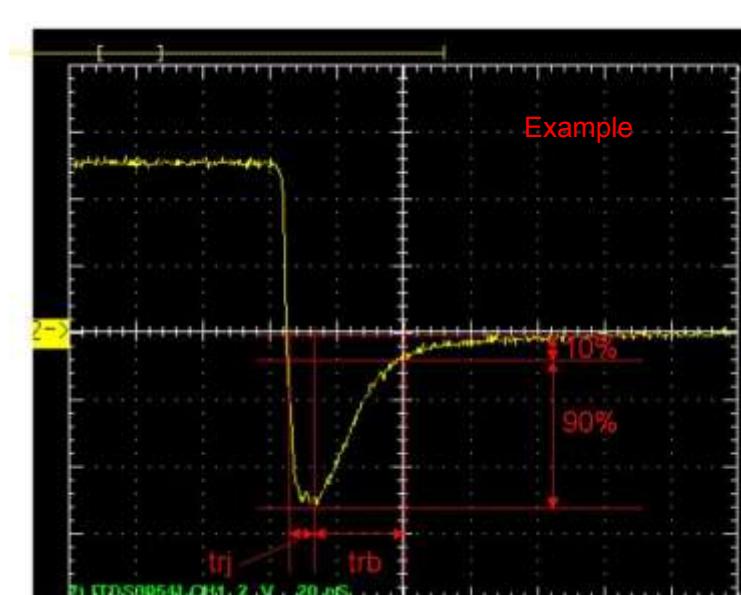
Reference



Trj= (72ns)

Trb= (245ns)

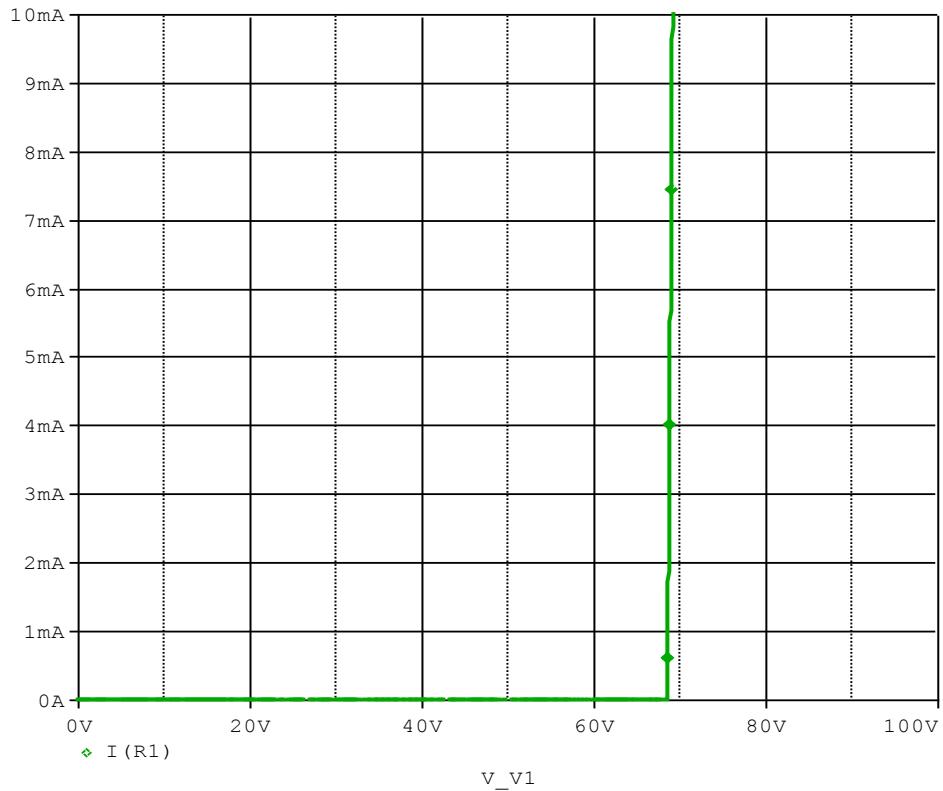
Conditions: Ifwd=Irev=0.2(A), RI=50



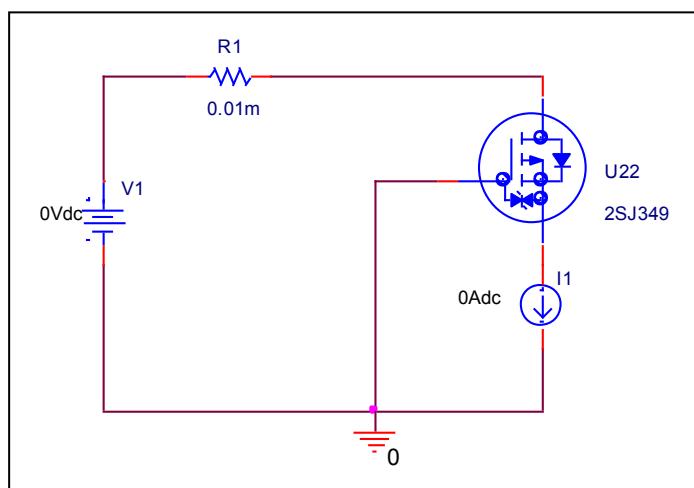
Relation between trj and trb

Zener Voltage Characteristic

Circuit Simulation Result

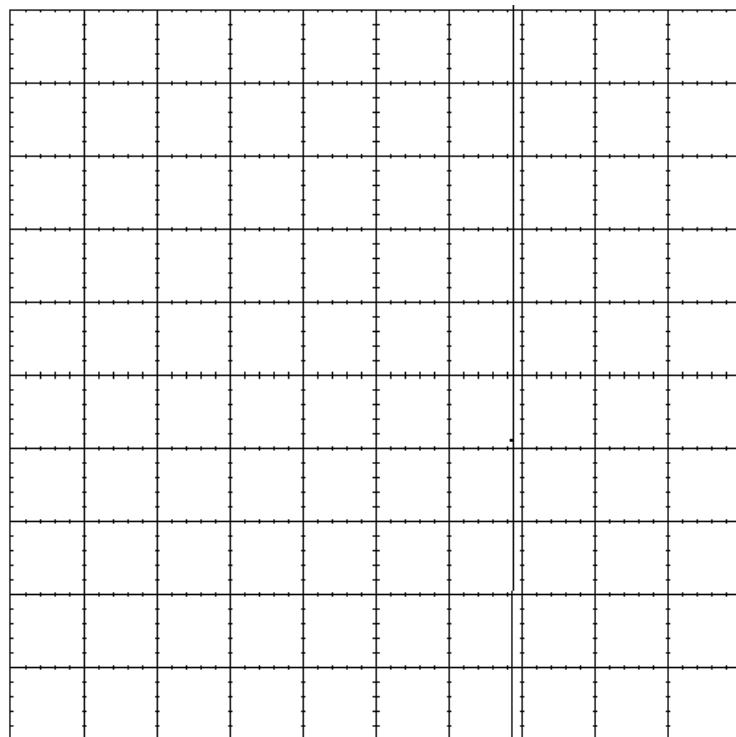


Evaluation Circuit



Zener Voltage Characteristic

Reference



VERT/DIV	1mA
CURSOR	(f: 1/grad.)
HORIZ/DIV	10 V
CURSOR	(f: intercept)
PER STEP	50mV
OFFSET	0.0mV
β OR gm/DIV	20mS
% of COLLECTOR PEAK VOLTS	0.0
AUX SUPPLY	0.00 V